

Notice of References Cited

Application/Contr.

09/661,684

Applicant(s)/Patent Under
Reexamination
SCHWABE, JUDITH E

Examiner

Wei Y Zhen

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6519767	02-2003	Carter et al	717/140
	B	US-5701408	12-1997	Cornell et al	395/183.14
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Lindsay et al. A generic model for fine grained configuration management including version control and traceability. IEEE. 1997. pp. 27-36.
	V	Bowles et al. A Comparison of Commercial Reliability Prediction Programs. IEEE. 1990. pp. 450-455.
	W	Cooper. Persistent Languages Facilitate the Implementation of Software Version Management. IEEE. 1989. pp. 56-65.
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.